

# International **IR** Rectifier

## **HEXFET® POWER MOSFET SURFACE MOUNT (LCC-18)**

PD - 94678

**IRF7E3704  
20V, N-CHANNEL**

### Product Summary

Part Number	BVDSS	RDS(on)	ID
IRF7E3704	20V	0.05Ω	12A*



Seventh Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon unit area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

These devices are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high-energy pulse circuits.

### Features:

- Low RDS(on)
- Avalanche Energy Ratings
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Light Weight
- Surface Mount

### Absolute Maximum Ratings

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	12*	A
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	10	
IDM	Pulsed Drain Current ①	48	
PD @ TC = 25°C	Max. Power Dissipation	20	W
	Linear Derating Factor	0.16	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	120	mJ
IAR	Avalanche Current ①	12	A
EAR	Repetitive Avalanche Energy ①	2.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③	1.0	V/ns
TJ	Operating Junction	-55 to 150	°C
TSTG	Storage Temperature Range		
	Pckg. Mounting Surface Temp.	300 (for 5s)	
	Weight	0.42 (Typical)	g

### Pre-Irradiation

\* Current is limited by package

For footnotes refer to the last page

**Electrical Characteristics @  $T_j = 25^\circ\text{C}$  (Unless Otherwise Specified)**

	Parameter	Min	Typ	Max	Units	Test Conditions
$\text{BV}_{\text{DSS}}$	Drain-to-Source Breakdown Voltage	20	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	Temperature Coefficient of Breakdown Voltage	—	0.023	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $\text{I}_D = 1.0\text{mA}$
$\text{R}_{\text{DS(on)}}$	Static Drain-to-Source On-State Resistance	—	—	0.05	$\Omega$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 10\text{A}$ ④
		—	—	0.055		$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 10\text{A}$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	1.0	—	3.0	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	14	—	—	S (Ω)	$\text{V}_{\text{DS}} = 10\text{V}, \text{I}_{\text{DS}} = 10\text{A}$ ④
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	—	—	20	$\mu\text{A}$	$\text{V}_{\text{DS}} = 20\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
		—	—	100		$\text{V}_{\text{DS}} = 16\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_j = 125^\circ\text{C}$
$\text{I}_{\text{GSS}}$	Gate-to-Source Leakage Forward	—	—	100	nA	$\text{V}_{\text{GS}} = 20\text{V}$
$\text{I}_{\text{GSS}}$	Gate-to-Source Leakage Reverse	—	—	-100		$\text{V}_{\text{GS}} = -20\text{V}$
$Q_g$	Total Gate Charge	—	—	22	nC	$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 12\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	—	10		$\text{V}_{\text{DS}} = 10\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ('Miller') Charge	—	—	6.0		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	—	16	ns	$\text{V}_{\text{DD}} = 10\text{V}, \text{I}_D = 12\text{A}, \text{V}_{\text{GS}} = 4.5\text{V}, \text{R}_G = 1.8\Omega$
$t_r$	Rise Time	—	—	100		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	—	26		
$t_f$	Fall Time	—	—	12		
$L_S + L_D$	Total Inductance	—	6.1	—	nH	Measured from the center of drain pad to center of source pad
$C_{\text{iss}}$	Input Capacitance	—	1850	—	pF	$\text{V}_{\text{GS}} = 0\text{V}, \text{V}_{\text{DS}} = 10\text{V}$ $f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	1005	—		
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	63	—		
$R_G$	Gate Resistance	—	2.6	—	Ω	$f = 1.6\text{MHz}$ , open drain

**Source-Drain Diode Ratings and Characteristics**

	Parameter	Min	Typ	Max	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	12*	A	$T_j = 25^\circ\text{C}, I_S = 12\text{A}, \text{V}_{\text{GS}} = 0\text{V}$ ④
$I_{\text{SM}}$	Pulse Source Current (Body Diode) ①	—	—	48		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.4	V	$T_j = 25^\circ\text{C}, I_F = 12\text{A}, dI/dt \leq 100\text{A}/\mu\text{s}$
$t_{\text{rr}}$	Reverse Recovery Time	—	—	50	ns	$V_{\text{DD}} \leq 16\text{V}$ ④
$Q_{\text{RR}}$	Reverse Recovery Charge	—	—	60	nC	
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ .				

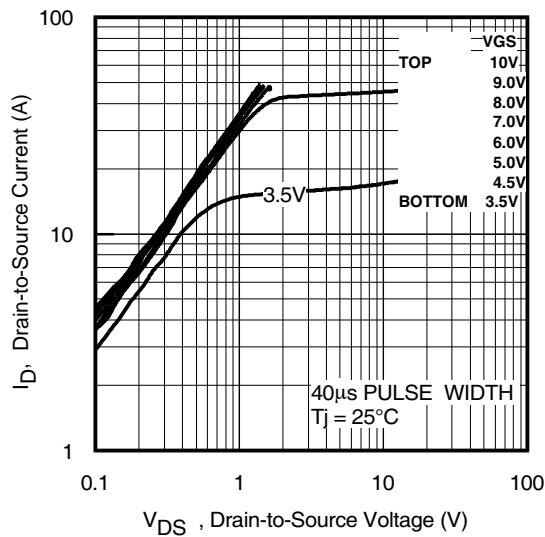
\* Current is limited by package

**Thermal Resistance**

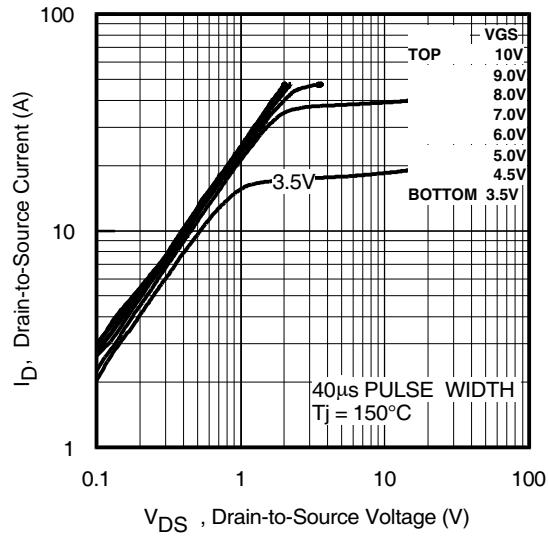
	Parameter	Min	Typ	Max	Units	Test Conditions
$R_{\text{thJC}}$	Junction-to-Case	—	—	6.25	$^\circ\text{C}/\text{W}$	

Note: Corresponding Spice and Saber models are available on International Rectifier Web site.

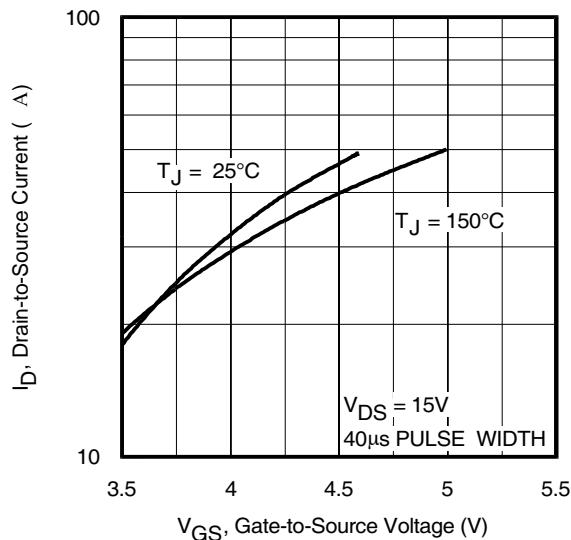
For footnotes refer to the last page



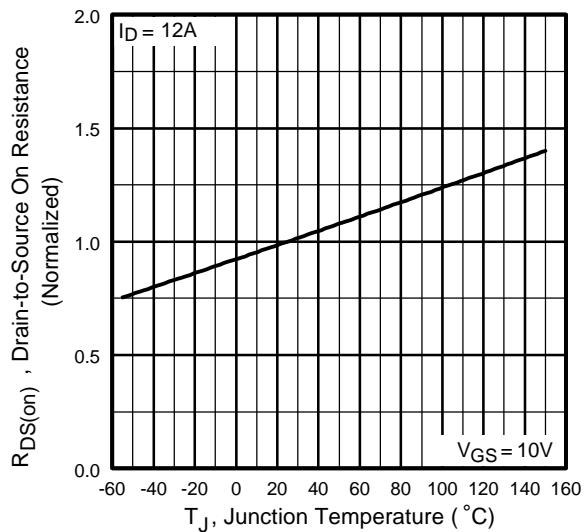
**Fig 1.** Typical Output Characteristics



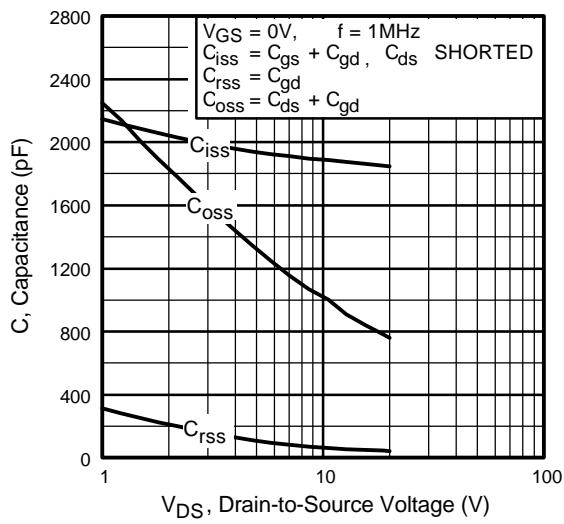
**Fig 2.** Typical Output Characteristics



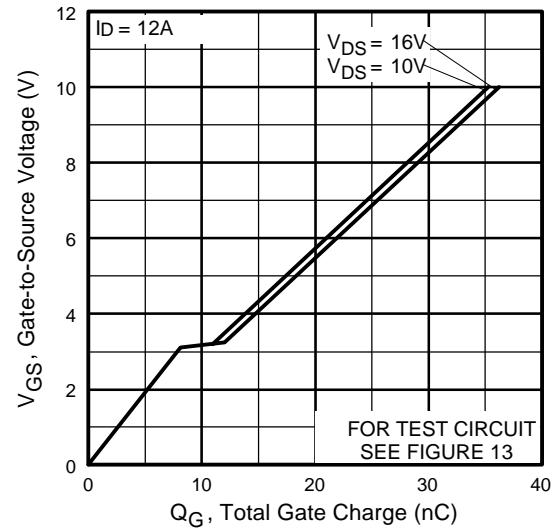
**Fig 3.** Typical Transfer Characteristics



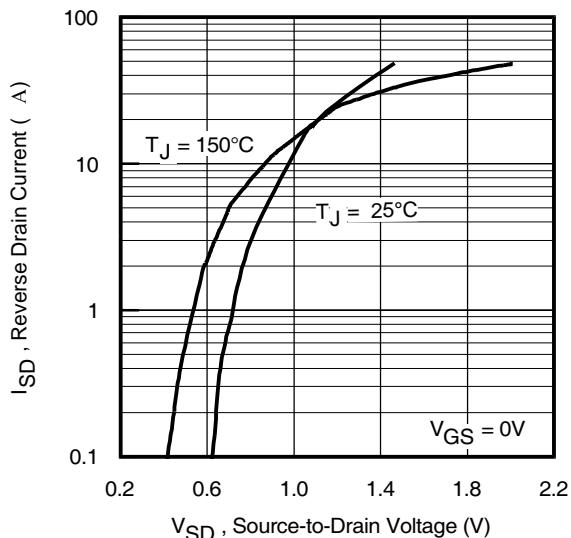
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



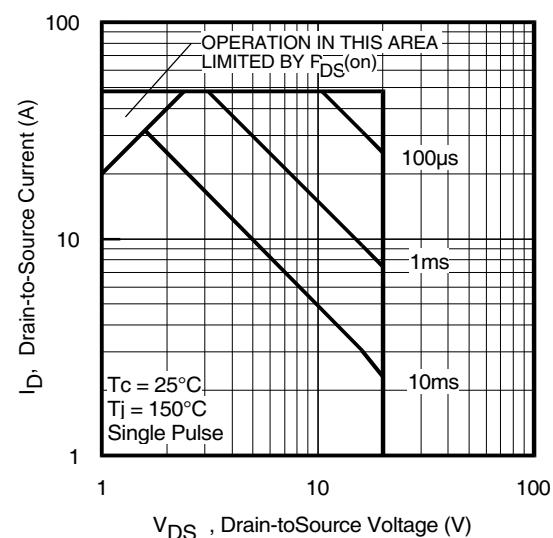
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



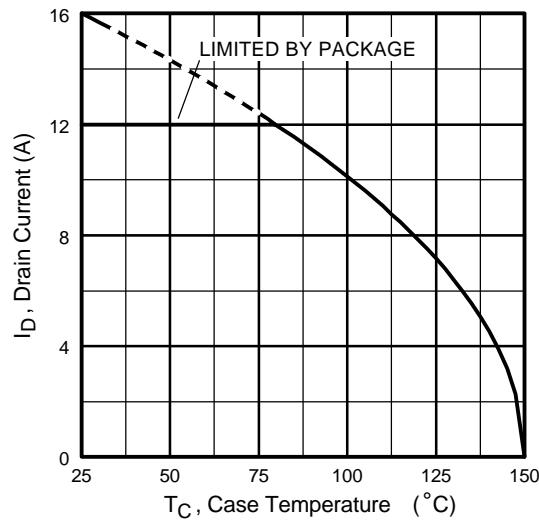
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



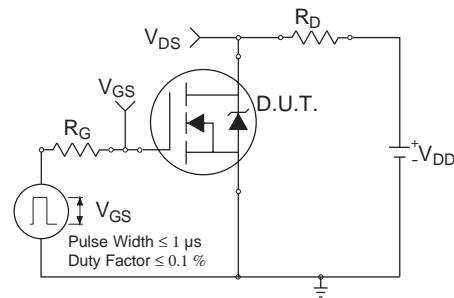
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



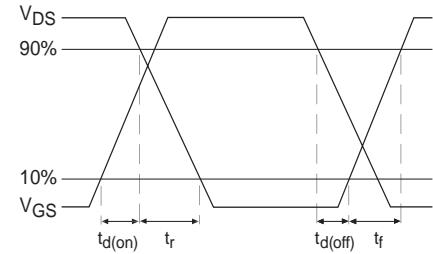
**Fig 8.** Maximum Safe Operating Area



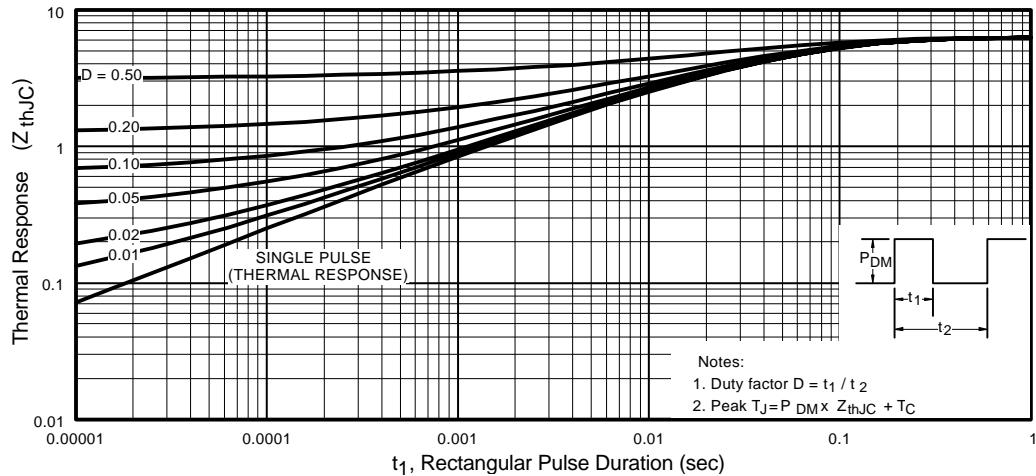
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

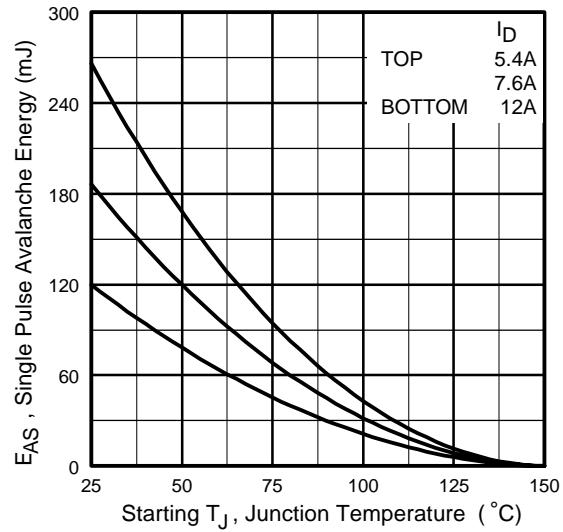
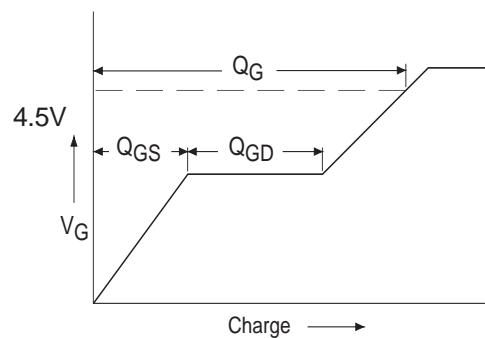
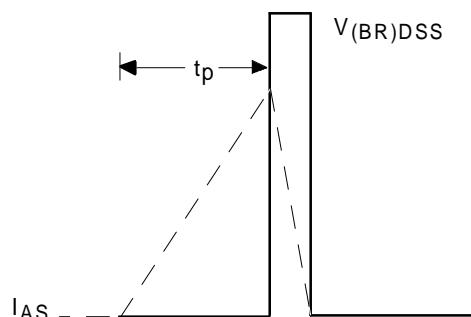
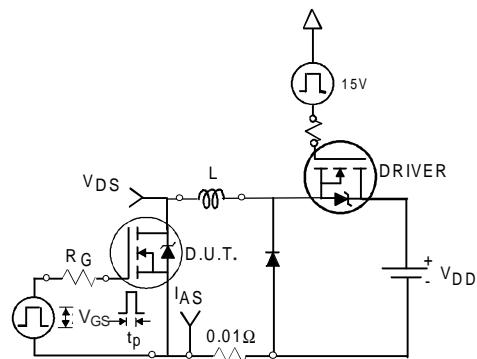
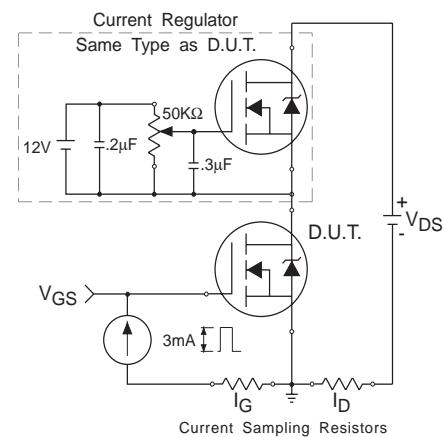


Fig 12c. Maximum Avalanche Energy  
Vs. Drain Current

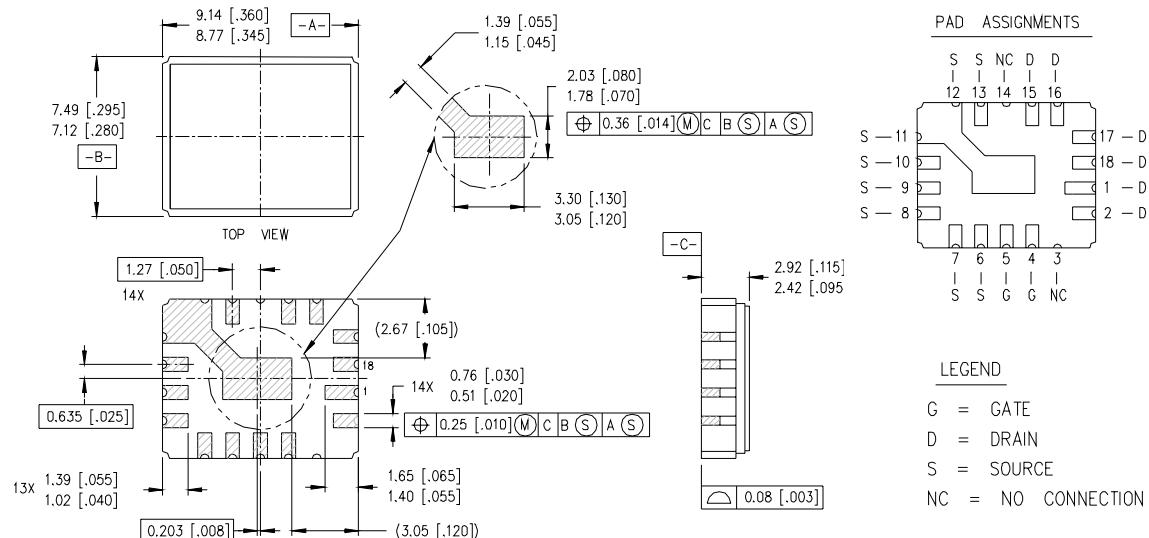


**Footnotes:**

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② V<sub>DD</sub> = 15V, starting T<sub>J</sub> = 25°C, L = 1.7mH  
Peak I<sub>AS</sub> = 12A, V<sub>GS</sub> = 10V, R<sub>G</sub> = 25Ω

- ③ I<sub>SD</sub> ≤ 12A, di/dt ≤ 100A/μs,  
V<sub>DD</sub> ≤ 20V, T<sub>J</sub> ≤ 150°C
- ④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%

**Case Outline and Dimensions — LCC-18**



**NOTES:**

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

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*Data and specifications subject to change without notice. 07/03*